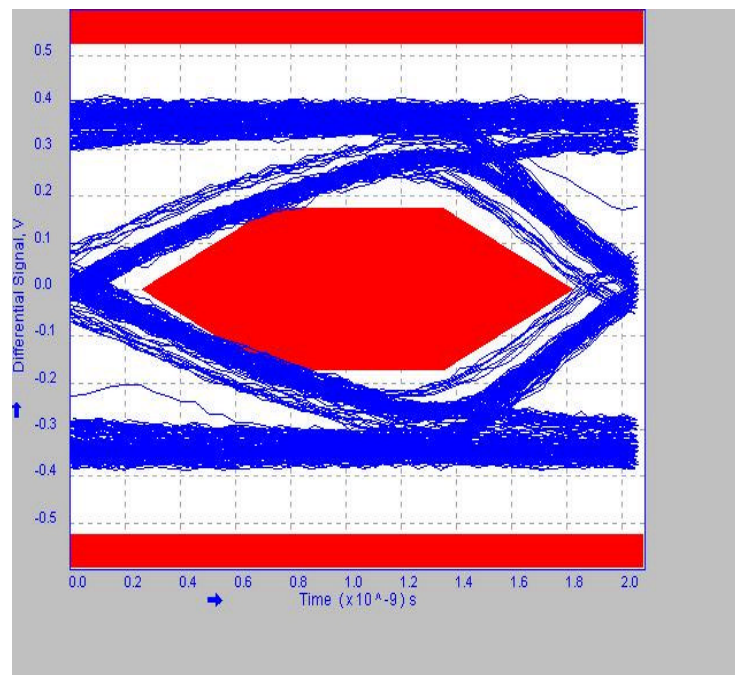
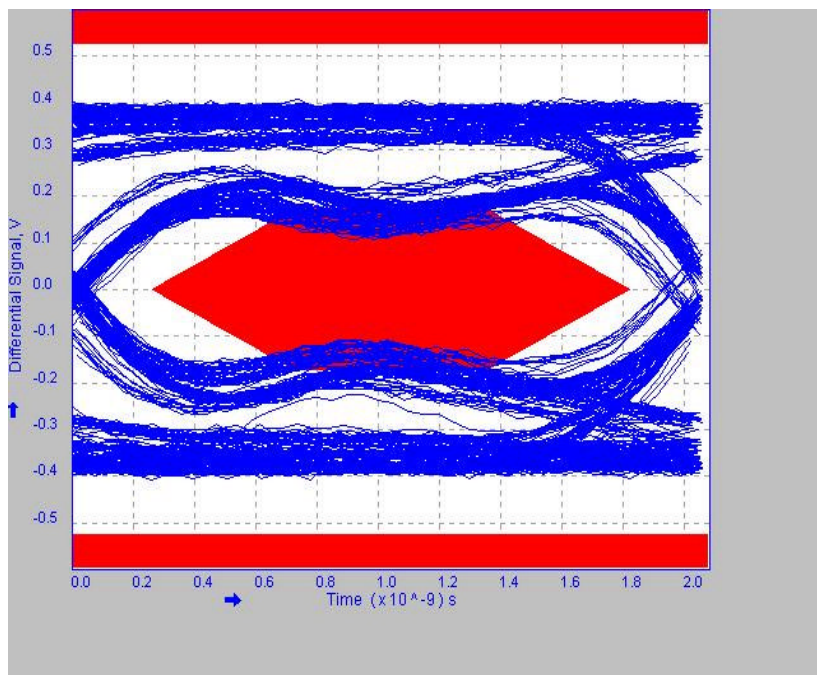


An Introduction:

Or

What is this talk really about?

Two pictures...



Measurement, Modeling and Simulation Techniques for High Speed Systems (Transmission Line Systems)

Assumptions

- High speed $\Rightarrow T_d/C > T_r$
 - T_r = rise-time,
 - C = velocity of propagation in the system and
 - T_d is the propagation time from one end to the other
- Low loss in package and bond
- ~ 0 -6dB loss in transmission system at $F_s/2$
- The goal is to understand the systems

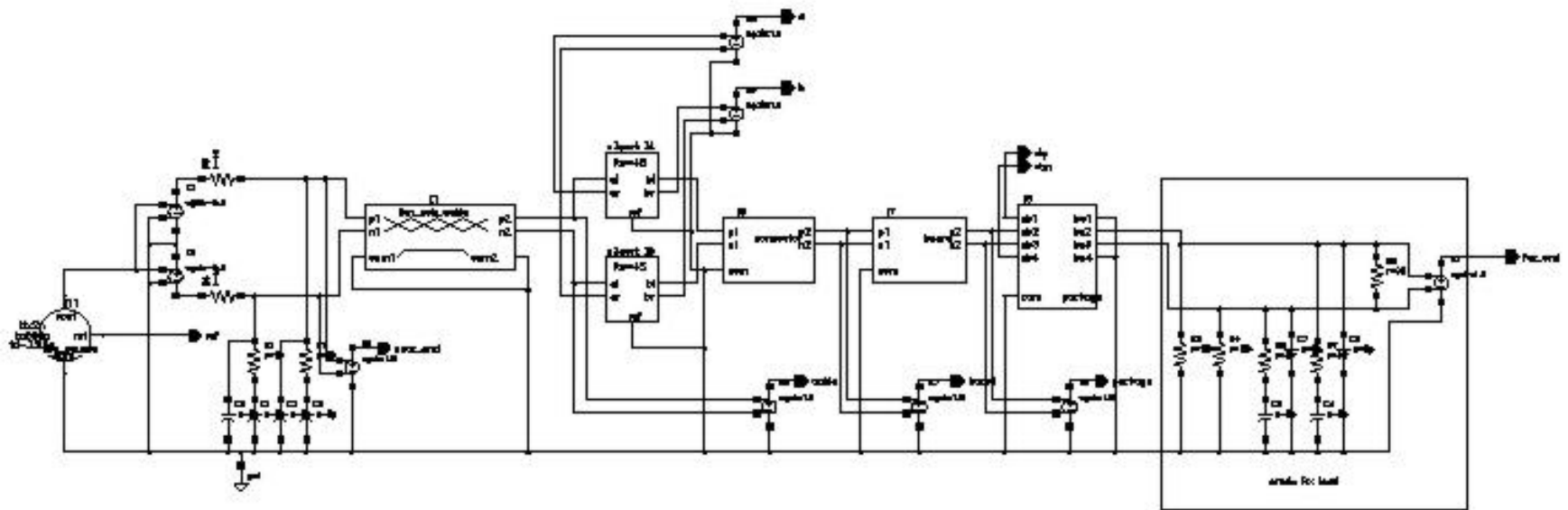
Assumptions

- Build up all models from pieces
 - They are more portable
 - The user/builder can understand them
 - Easier to tease out interactions
- Switch to the Hspice W element, or equivalent, after everything is well understood –not covered in this talk-

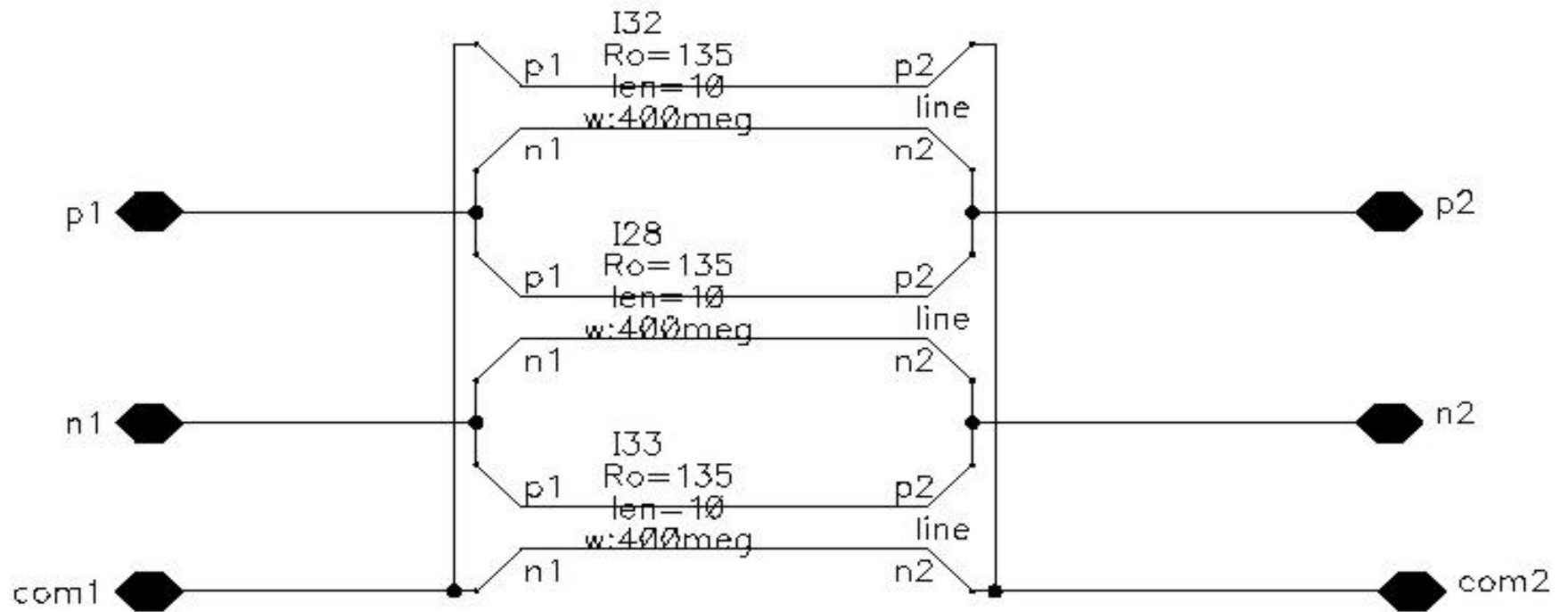
Case studies

- Non-ideal terminated receiver
- Package and bond wires
- Plating stubs

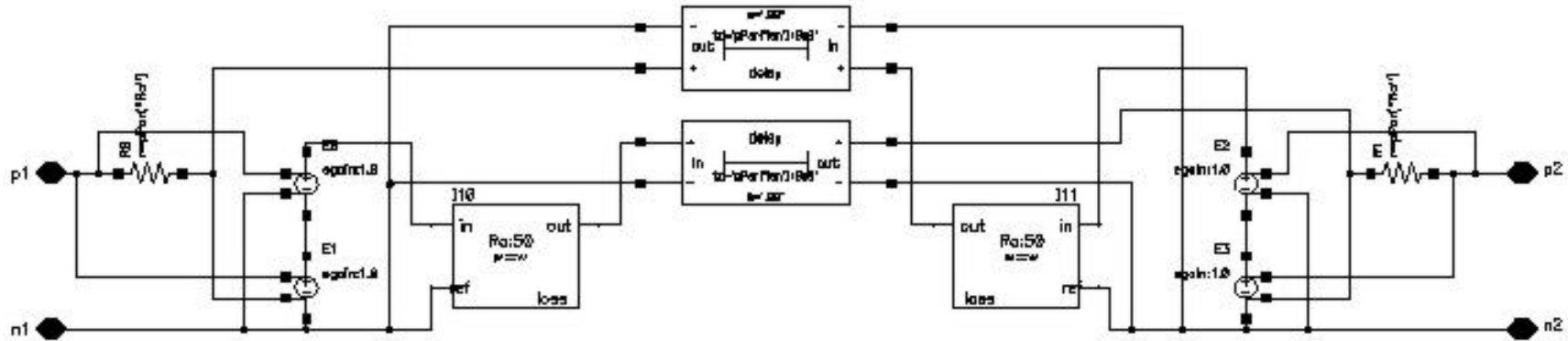
RX test circuit



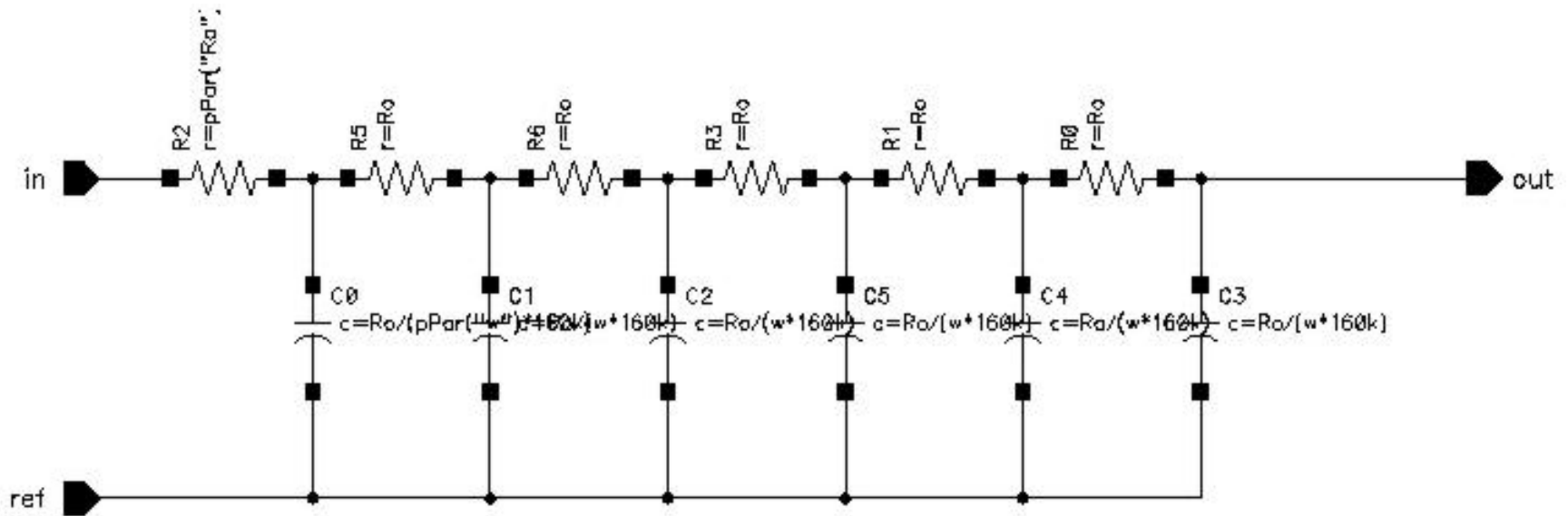
Cable model



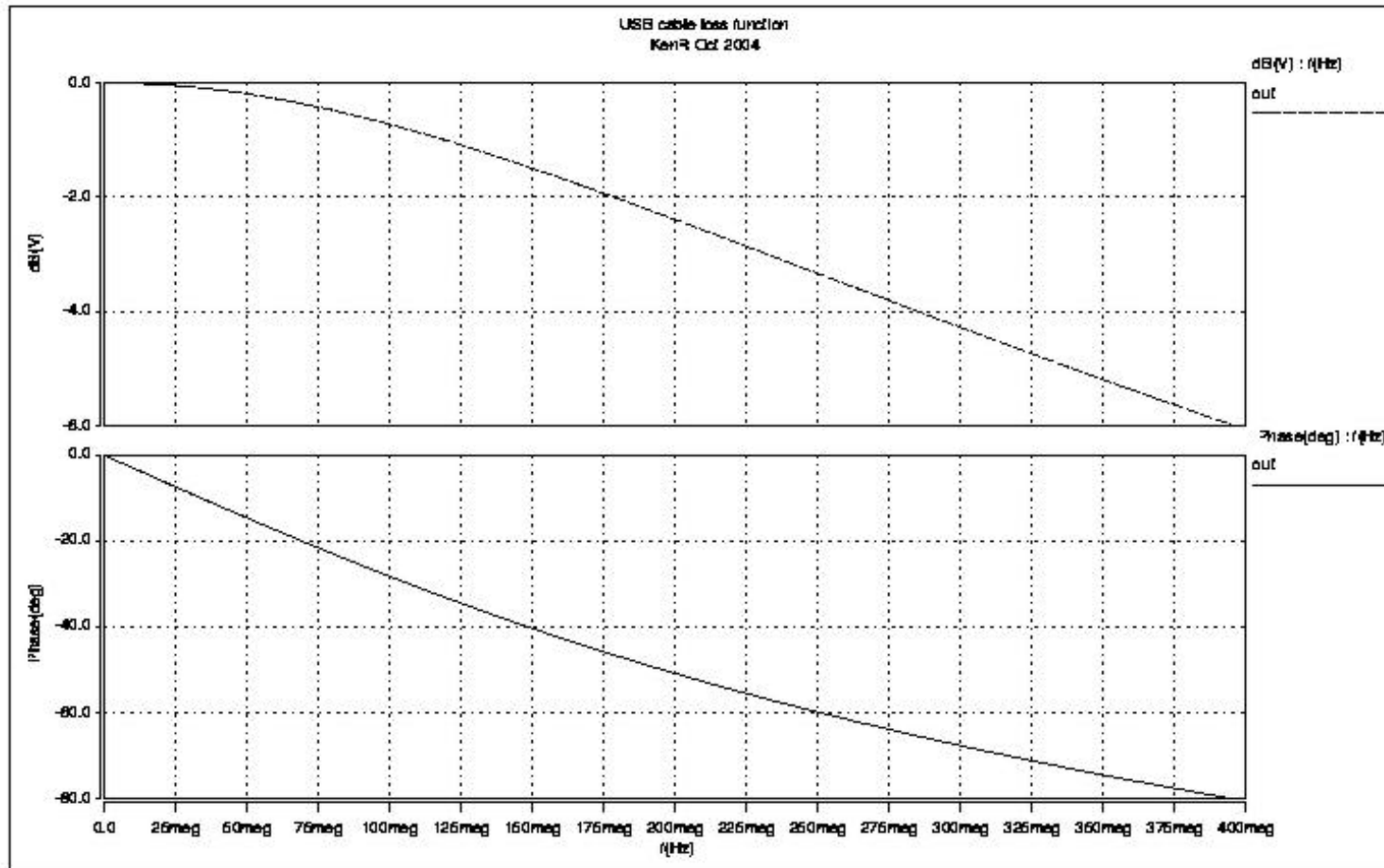
Transmission line model



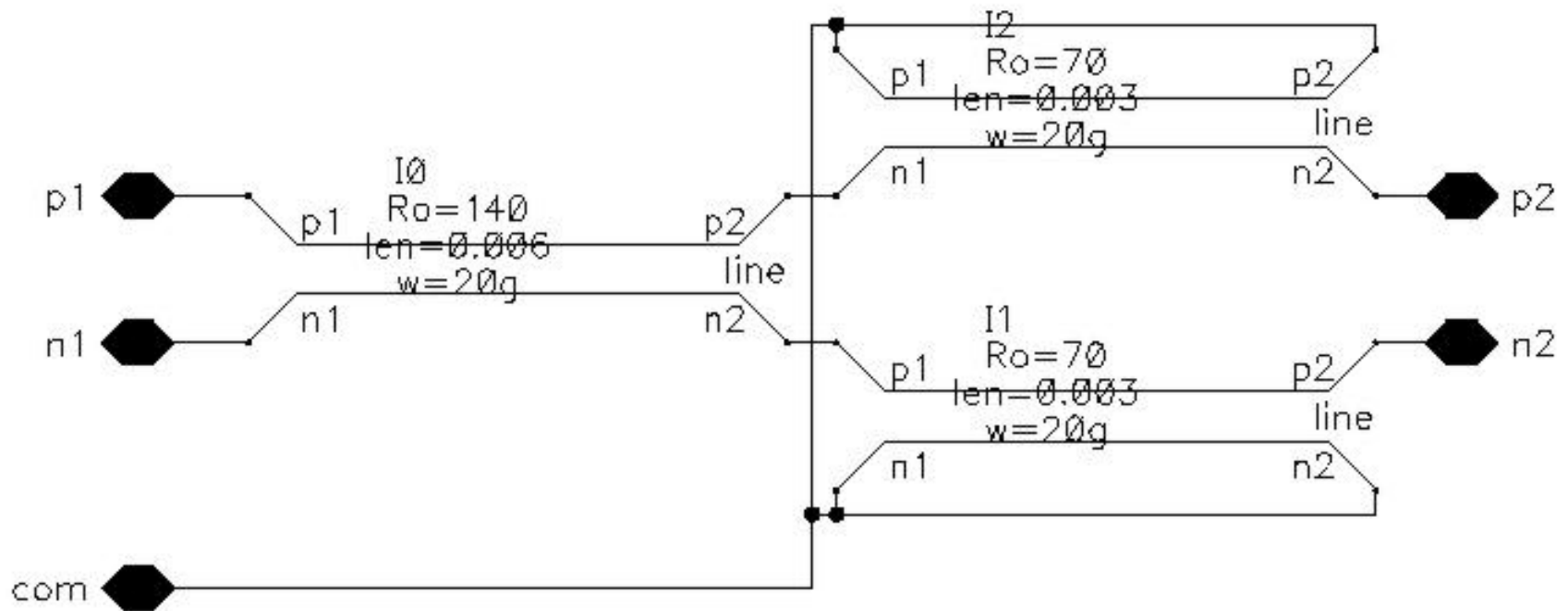
Cable loss model



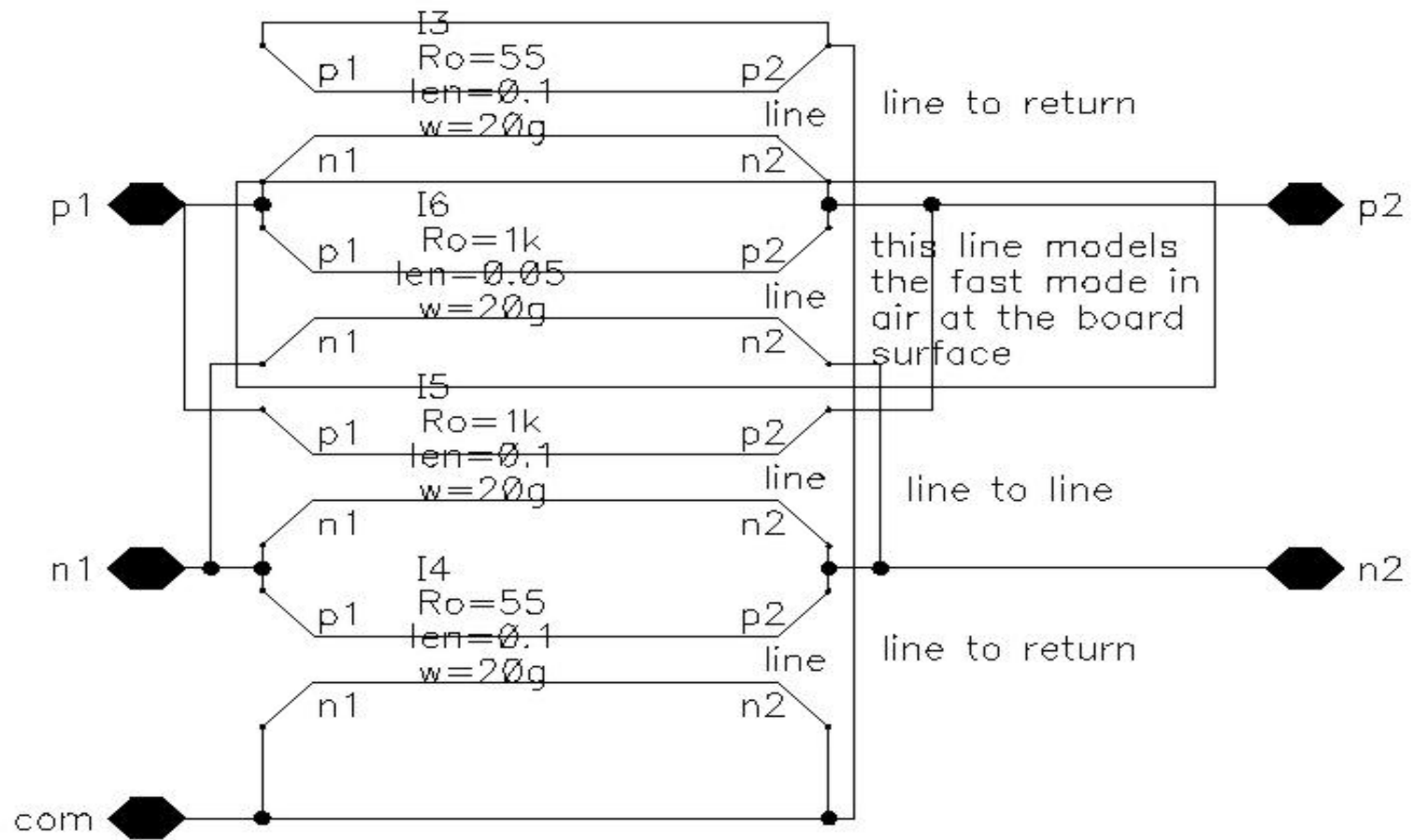
Cable loss characteristic



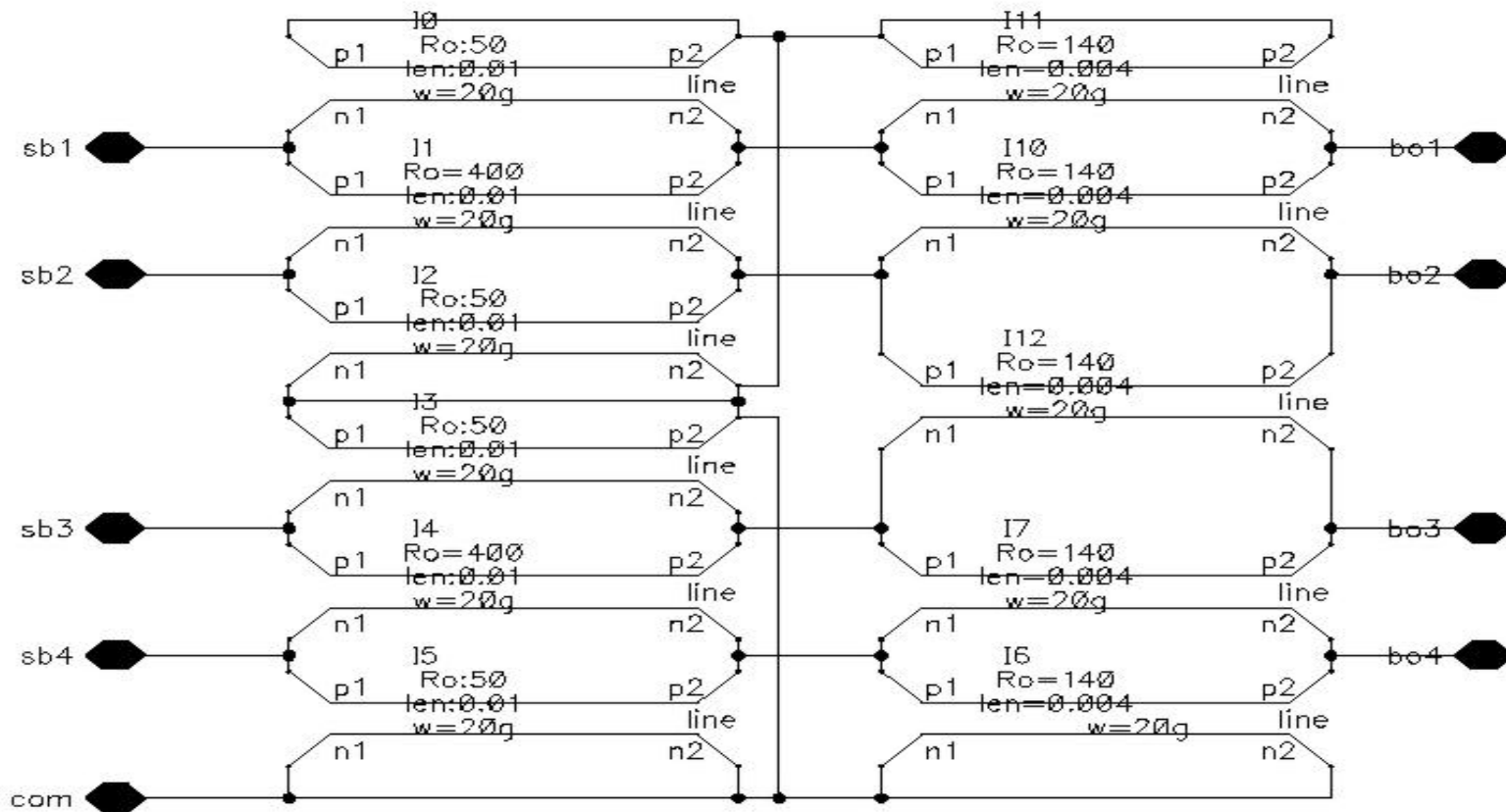
Connector model



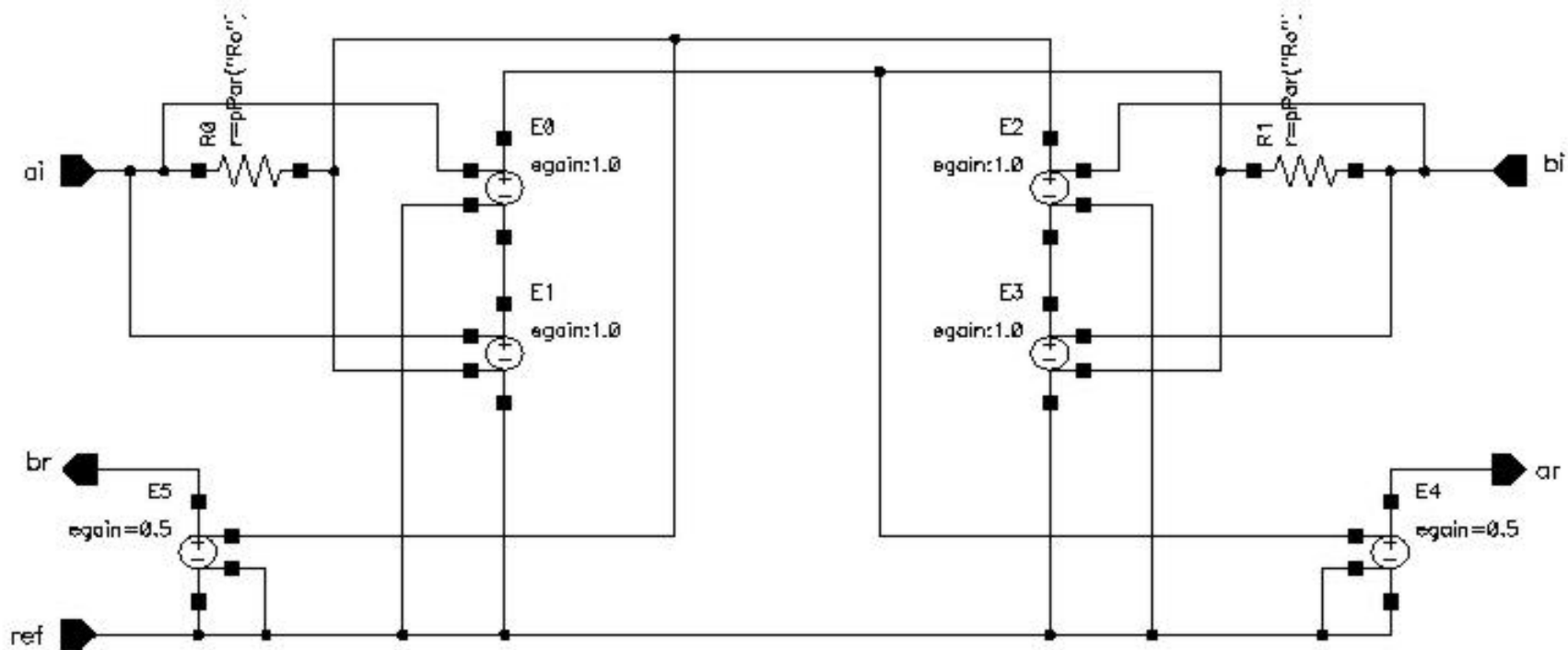
Board model



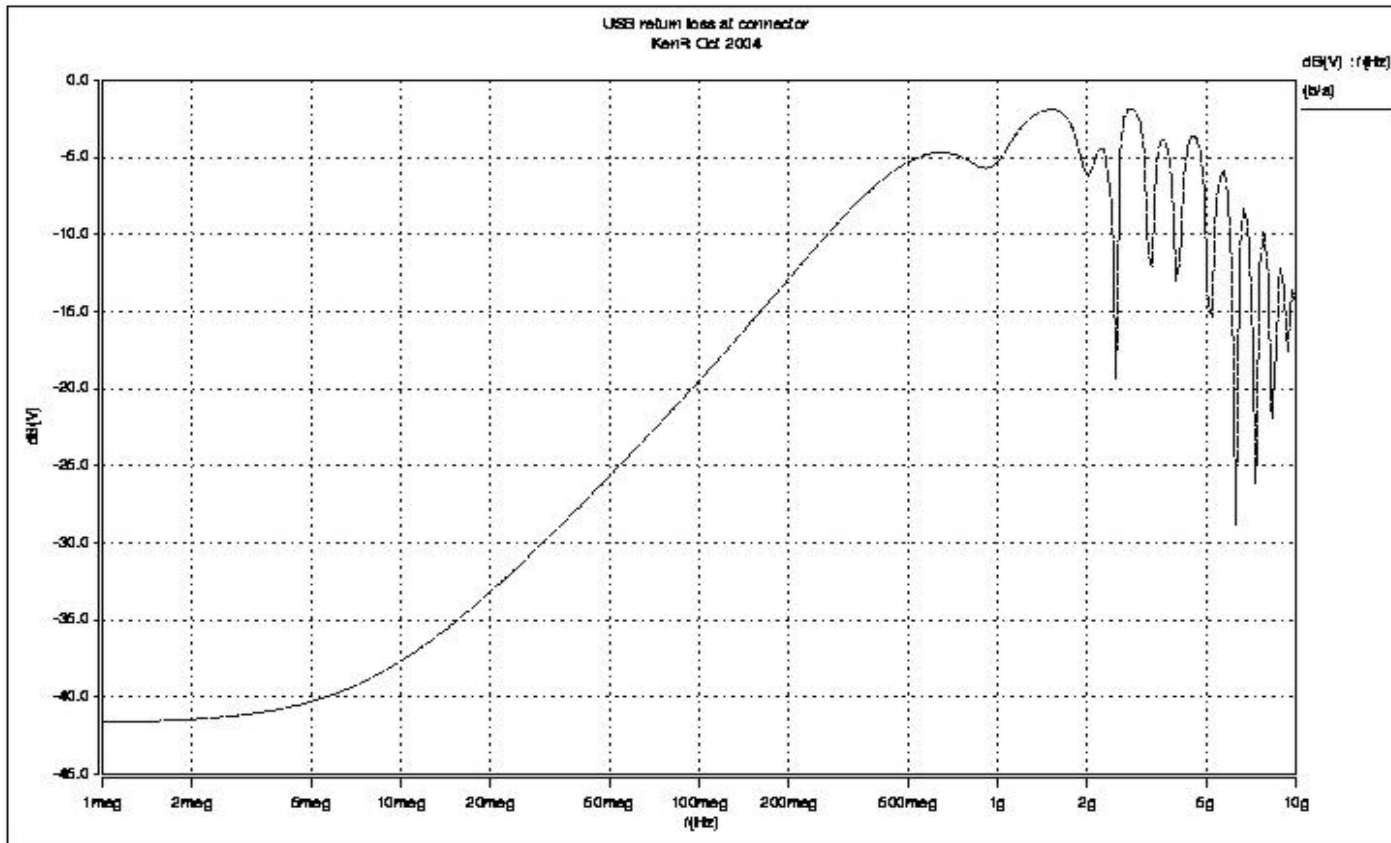
Package and bond model



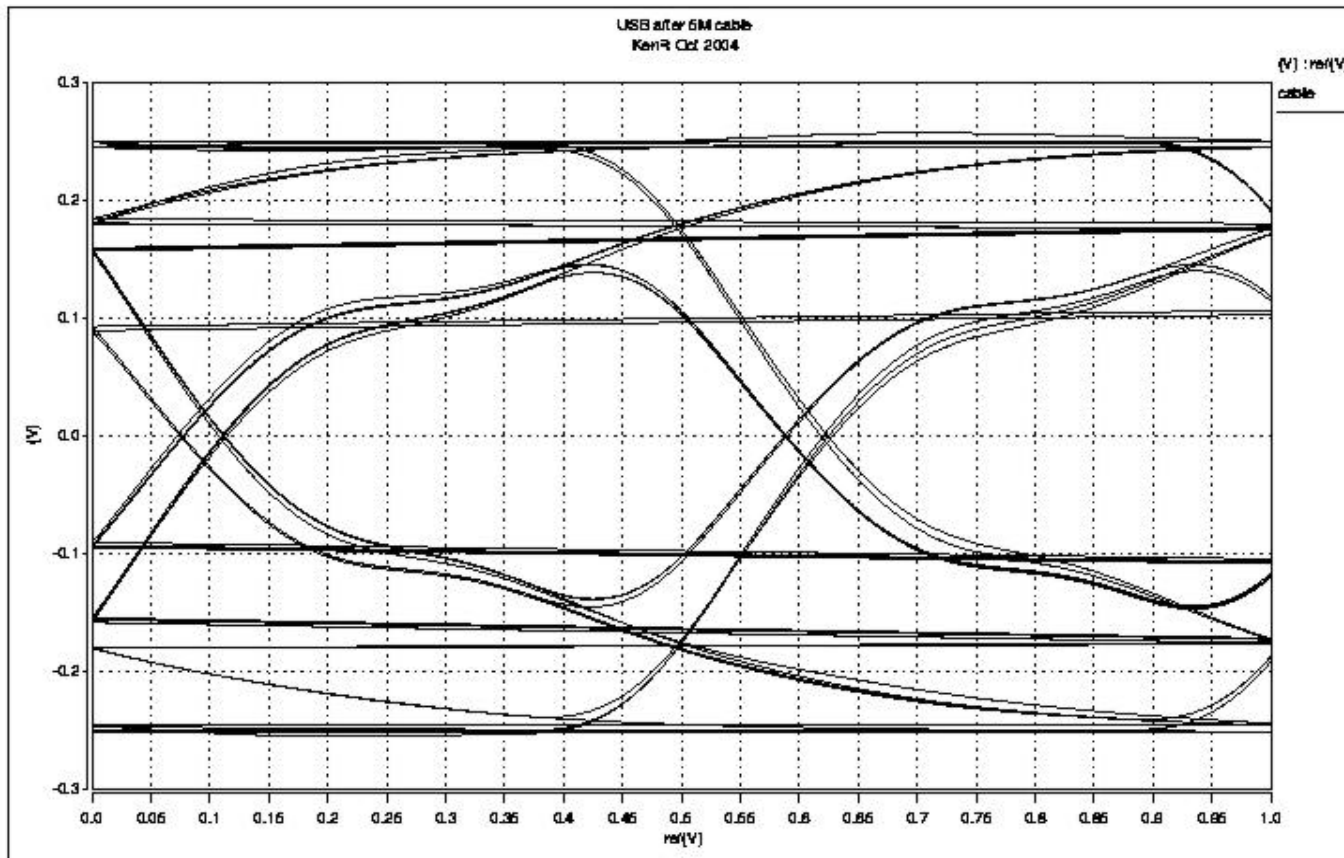
Directional coupler model



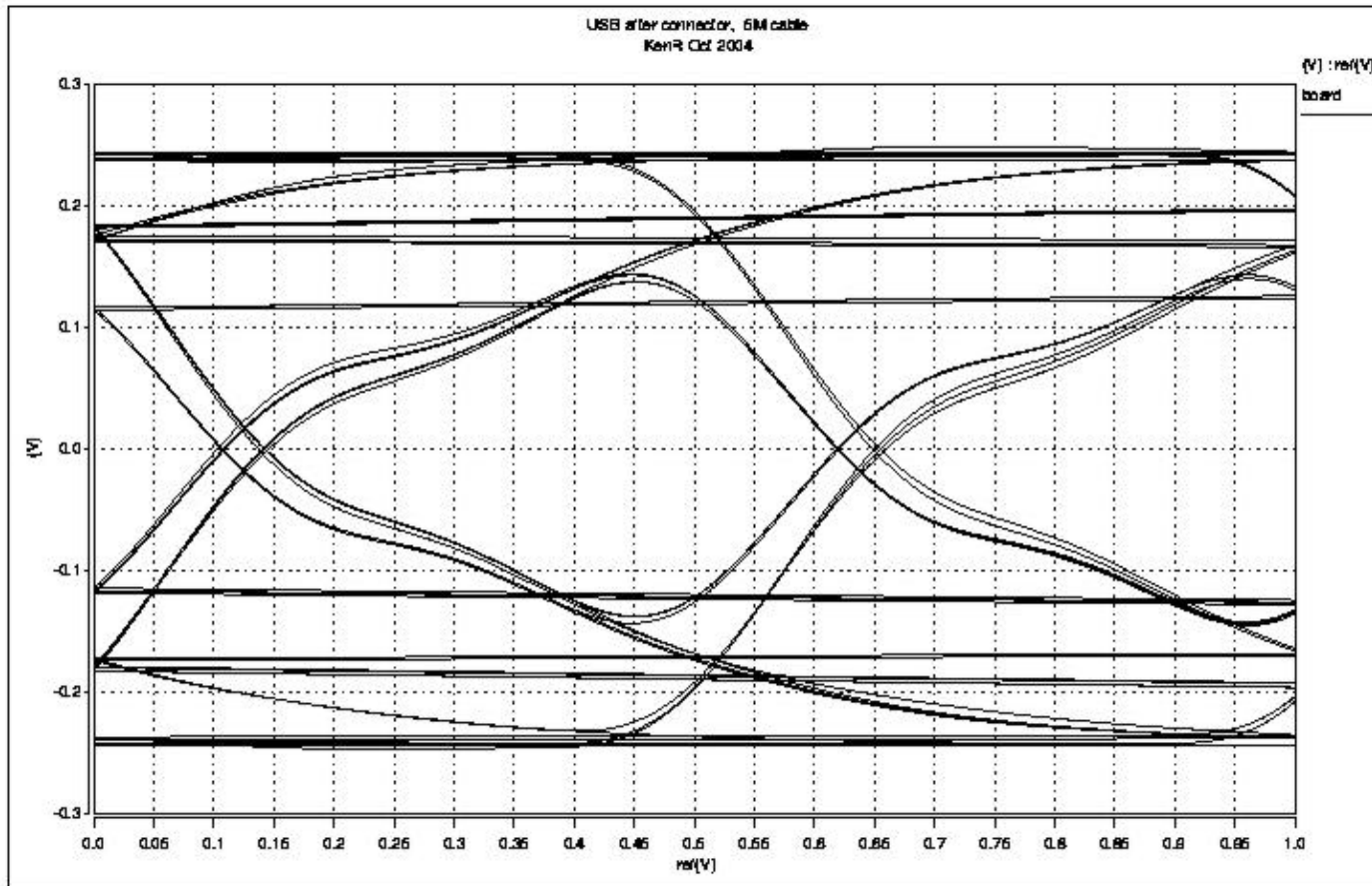
Return loss at connector



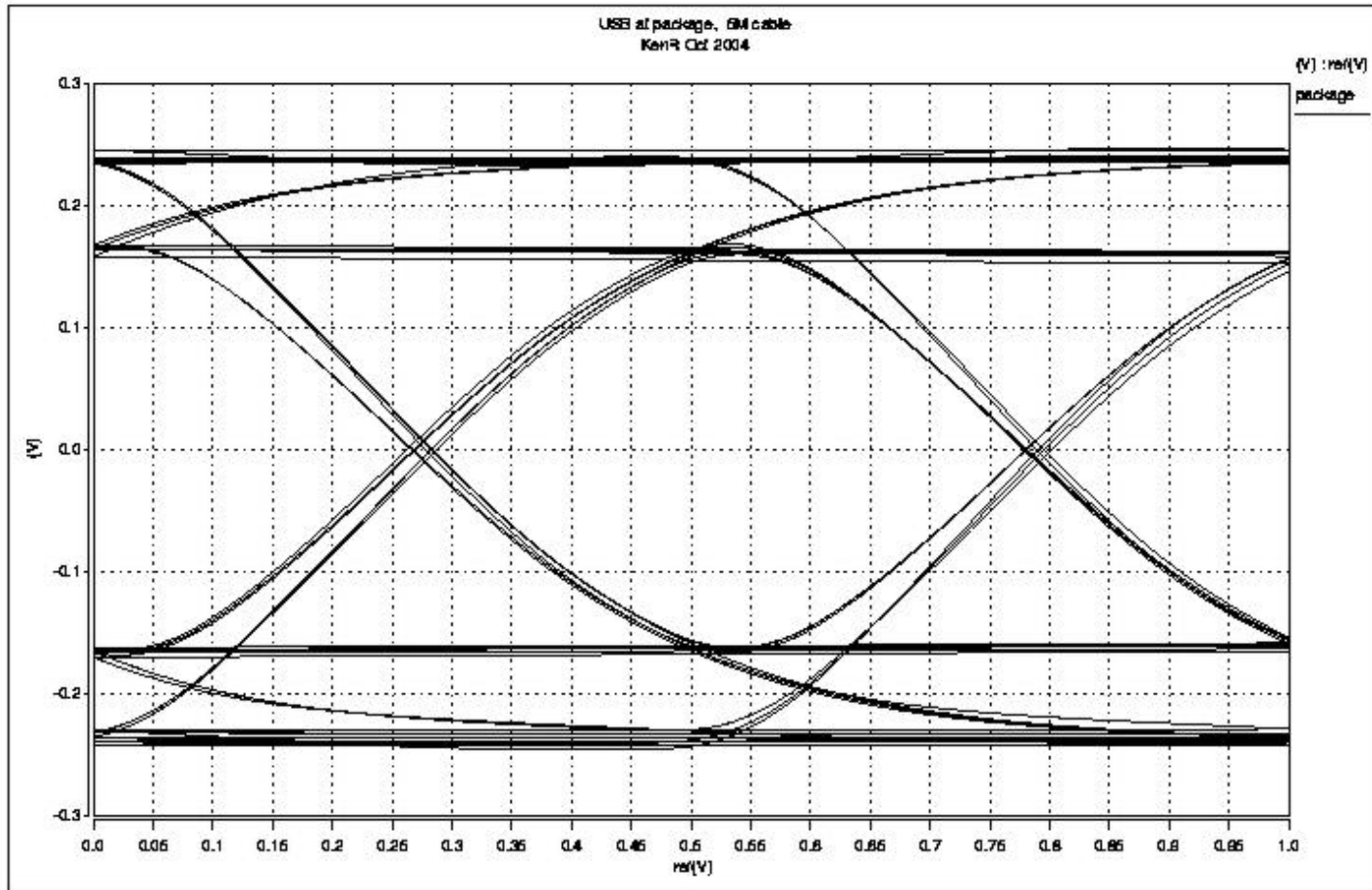
At the cable end



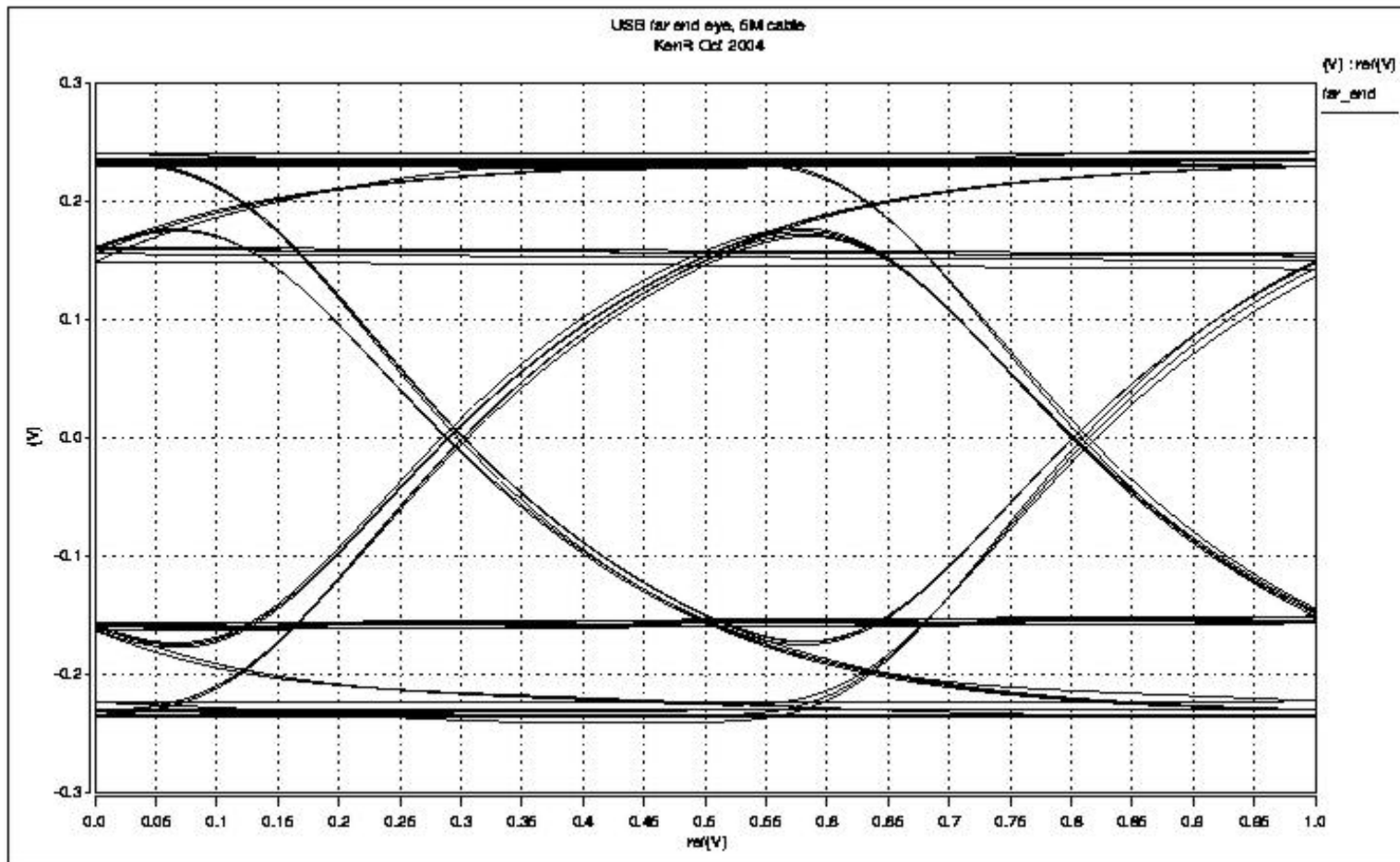
After the connector



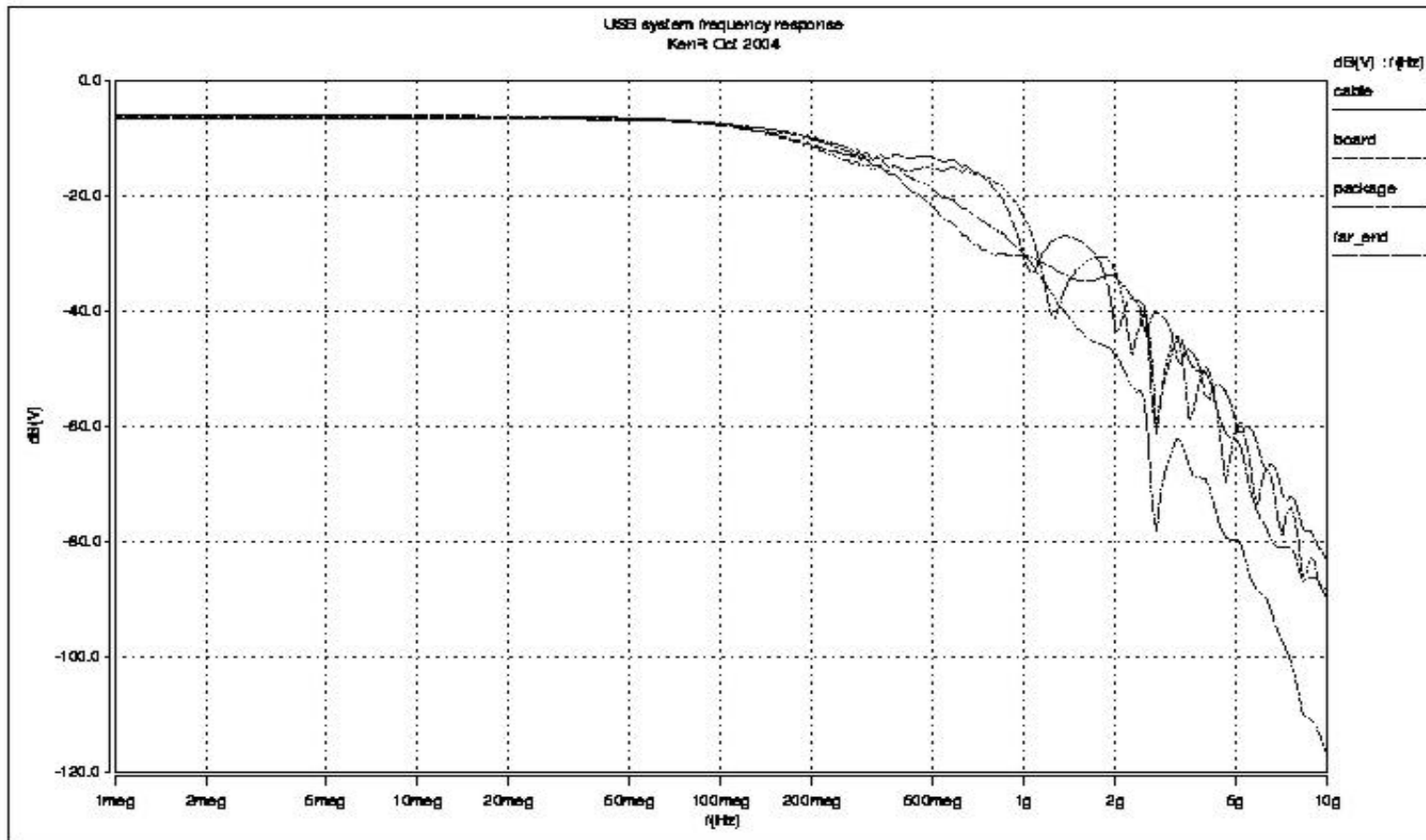
After 5cm of board



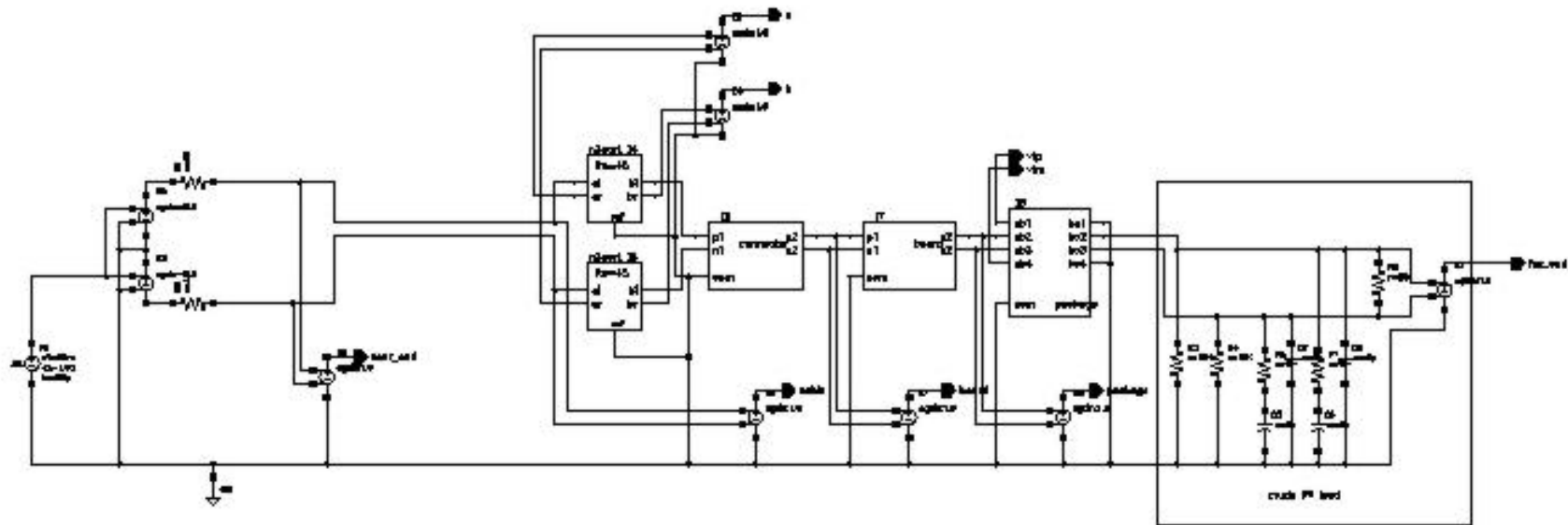
On the chip at the terminator



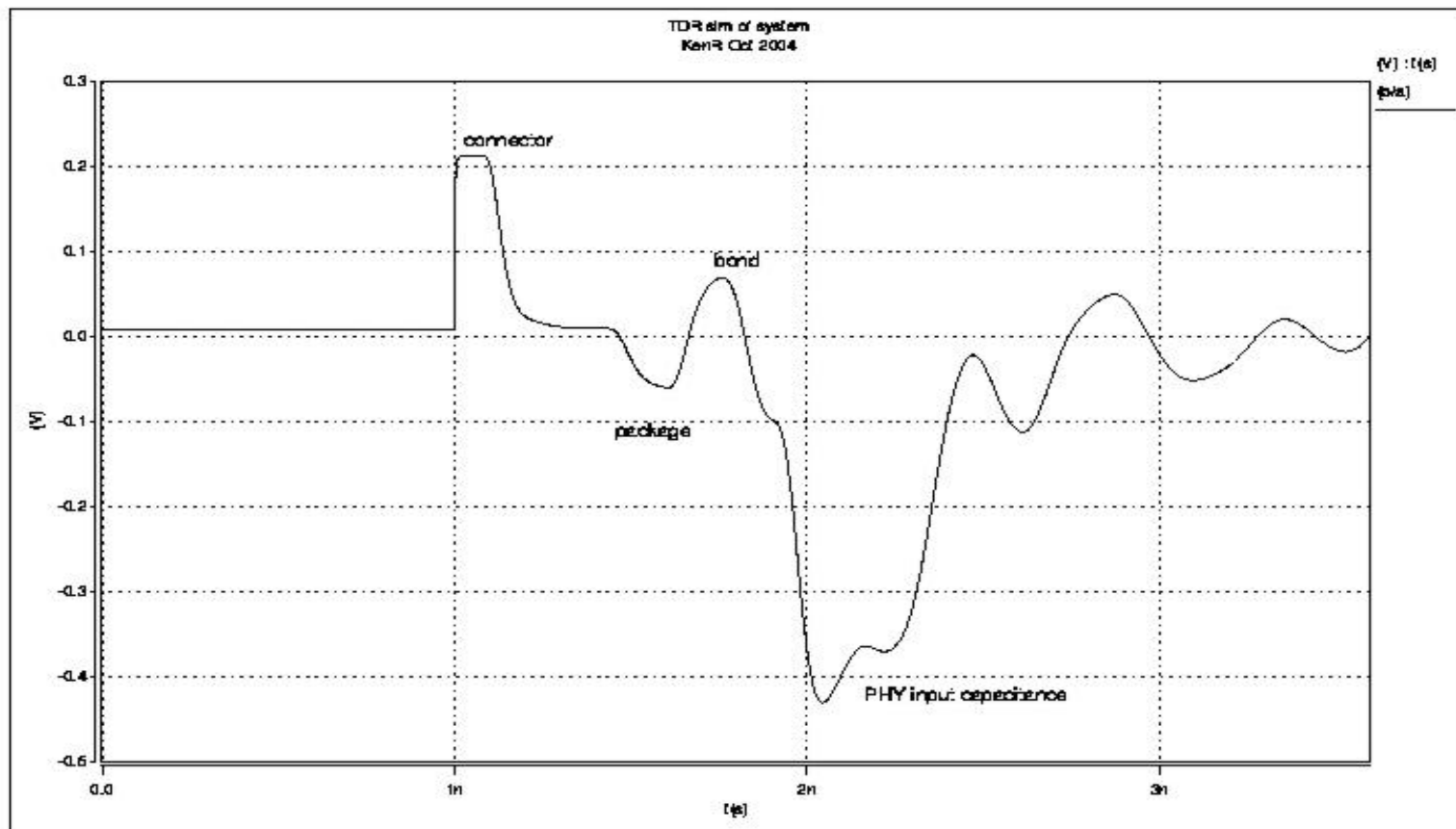
System frequency response



TDR sim test bench



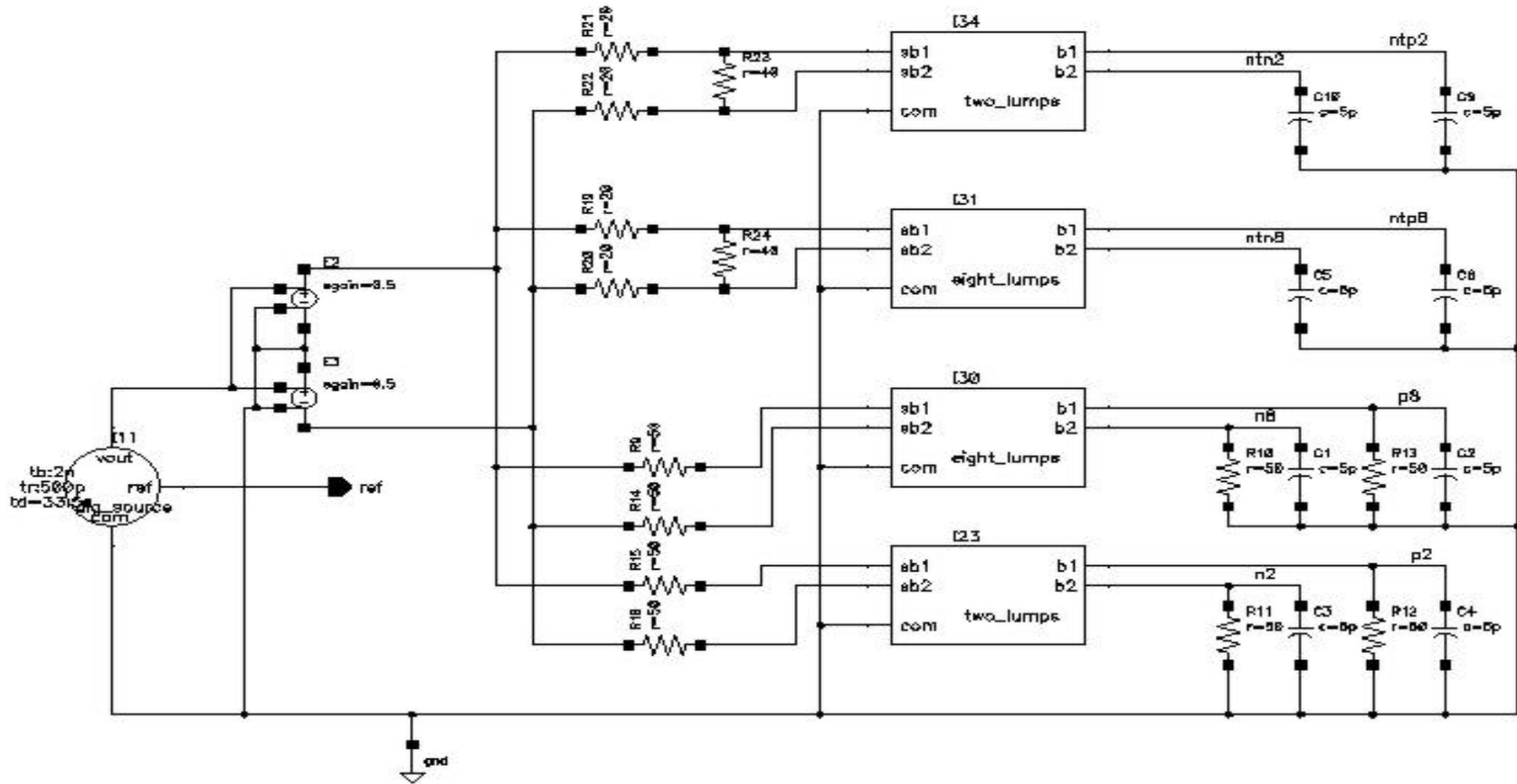
TDR sim result



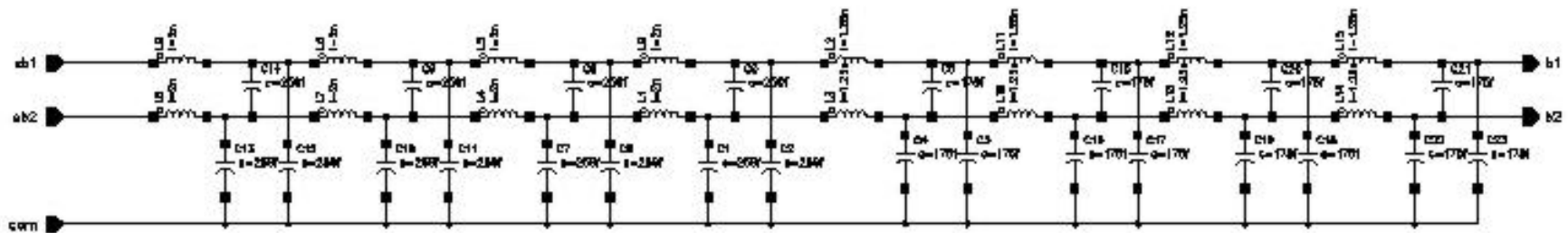
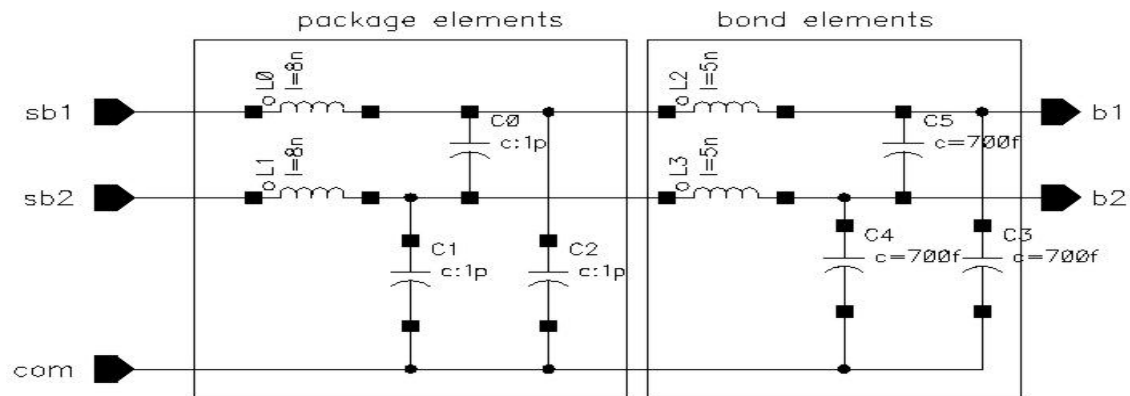
Package and bond wires

- Single lumped models:
 - Watch out above 100-200MHz
 - Break into more lumps based on extracted data
 - Can extract a small group of pins by hand
 - Use a solver

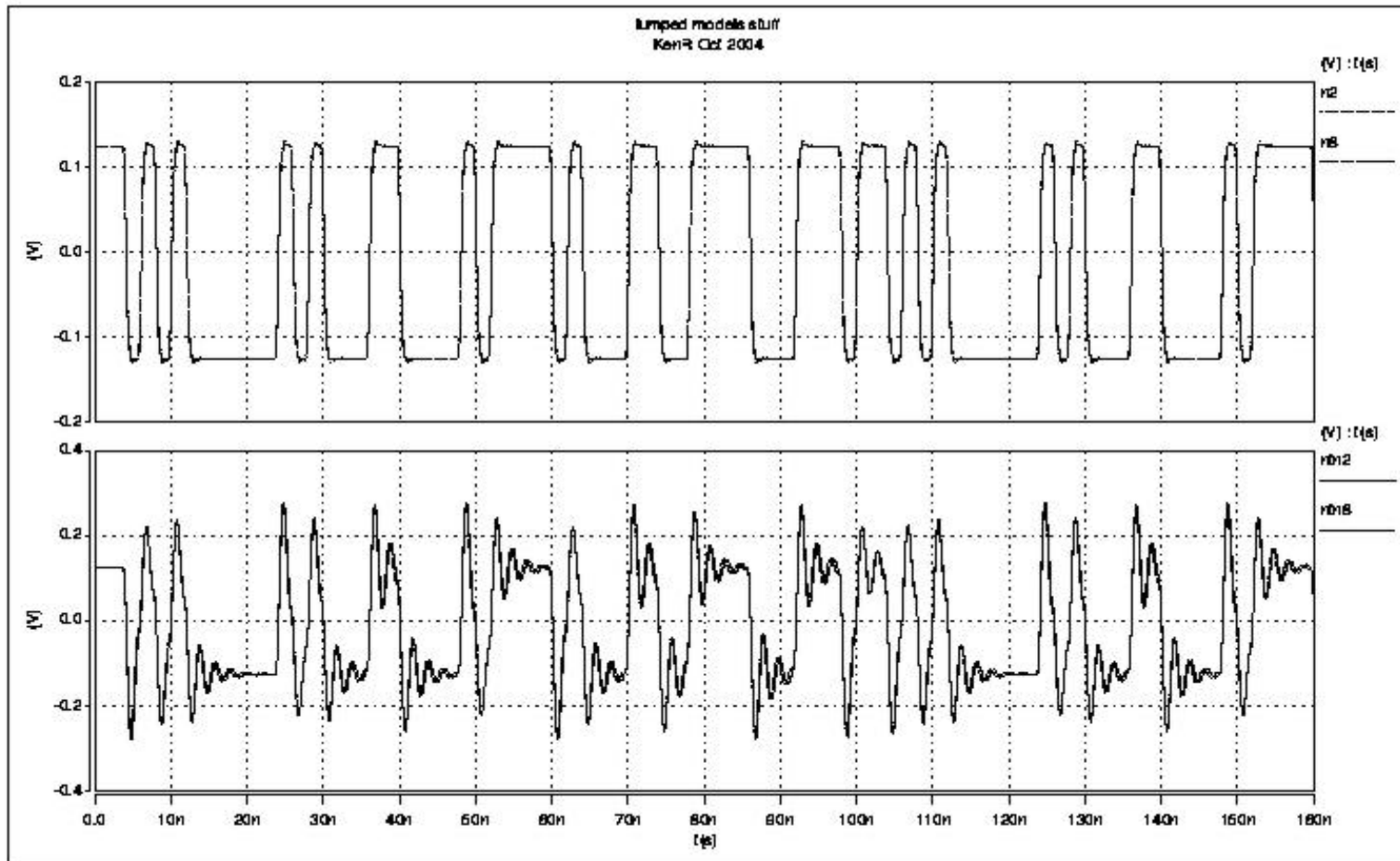
Lumped model test bench



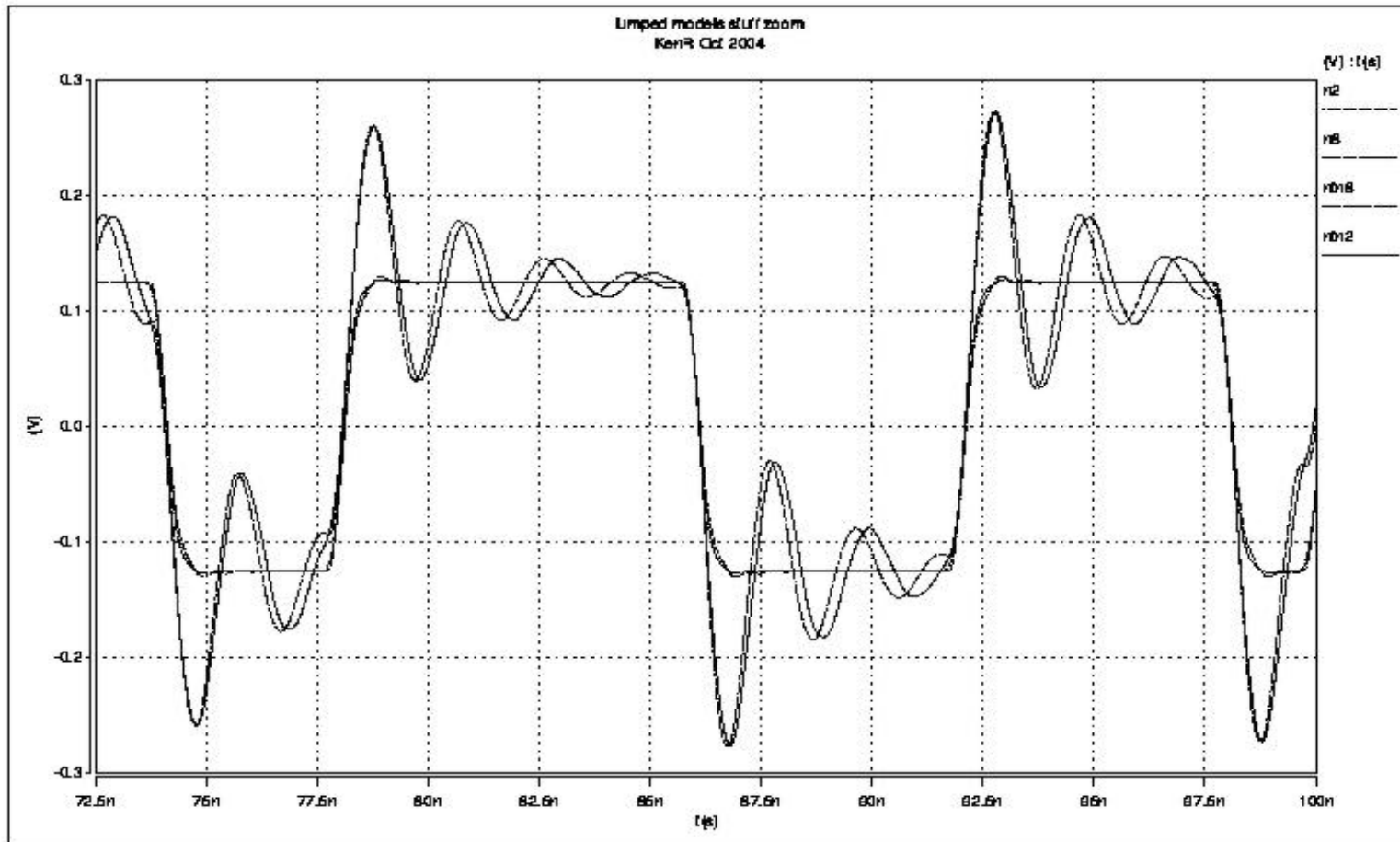
2 lumps and 8 lumps



Lumped results



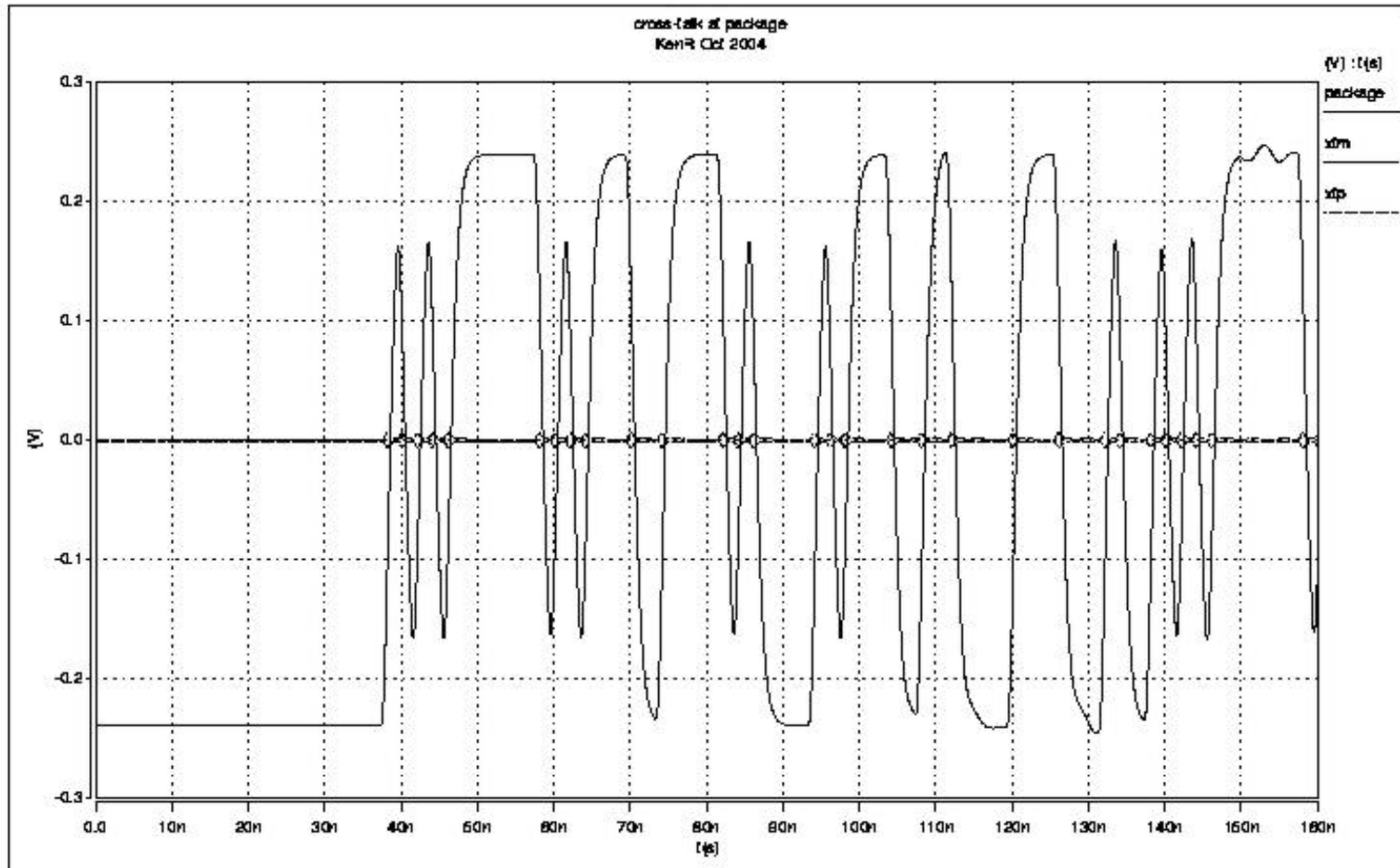
Lumped models



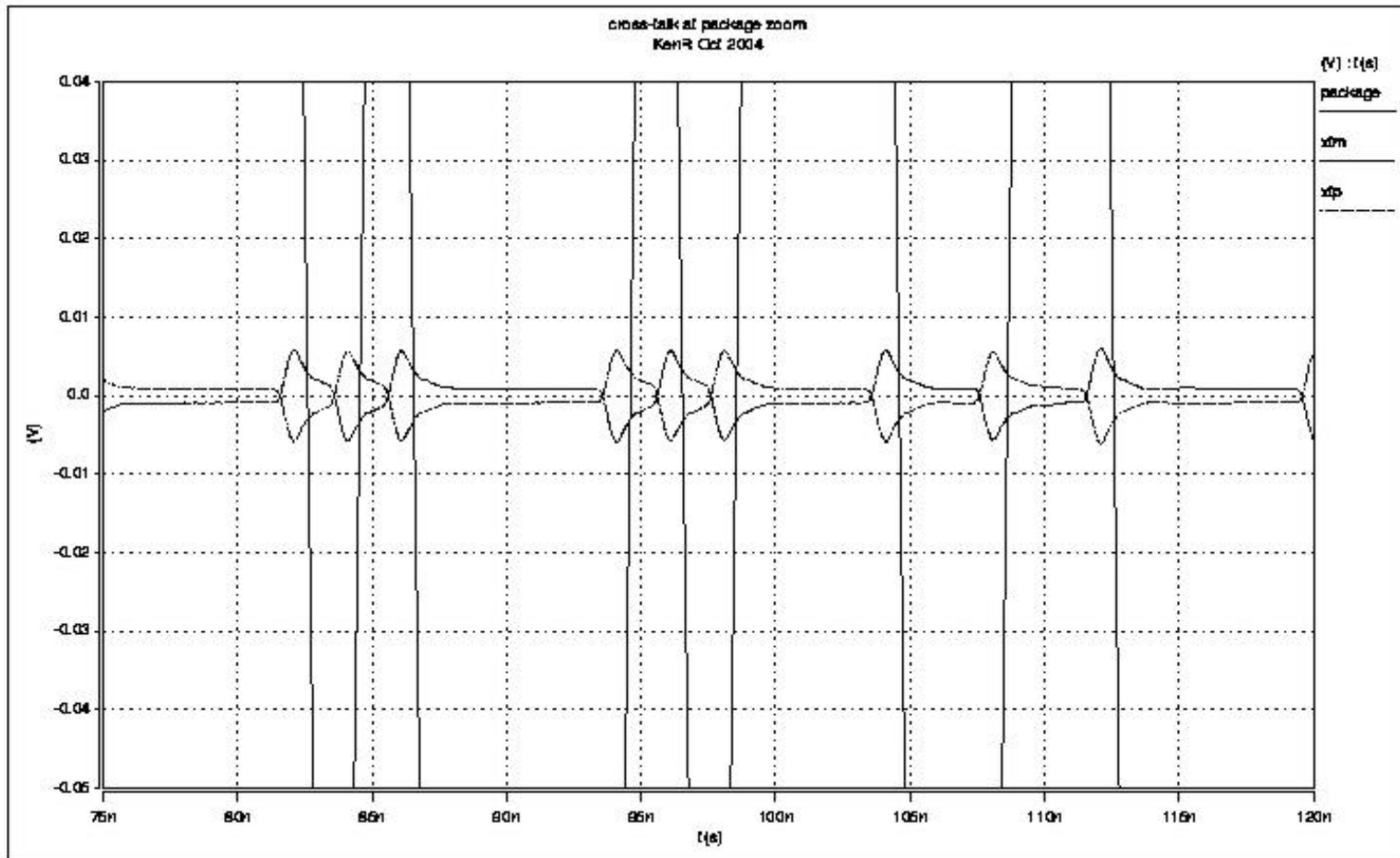
Cross-talk

- Interconnected transmission lines generally do the trick.
- Hspice W element is really good but try getting one quickly.

Obligatory cross-talk slide

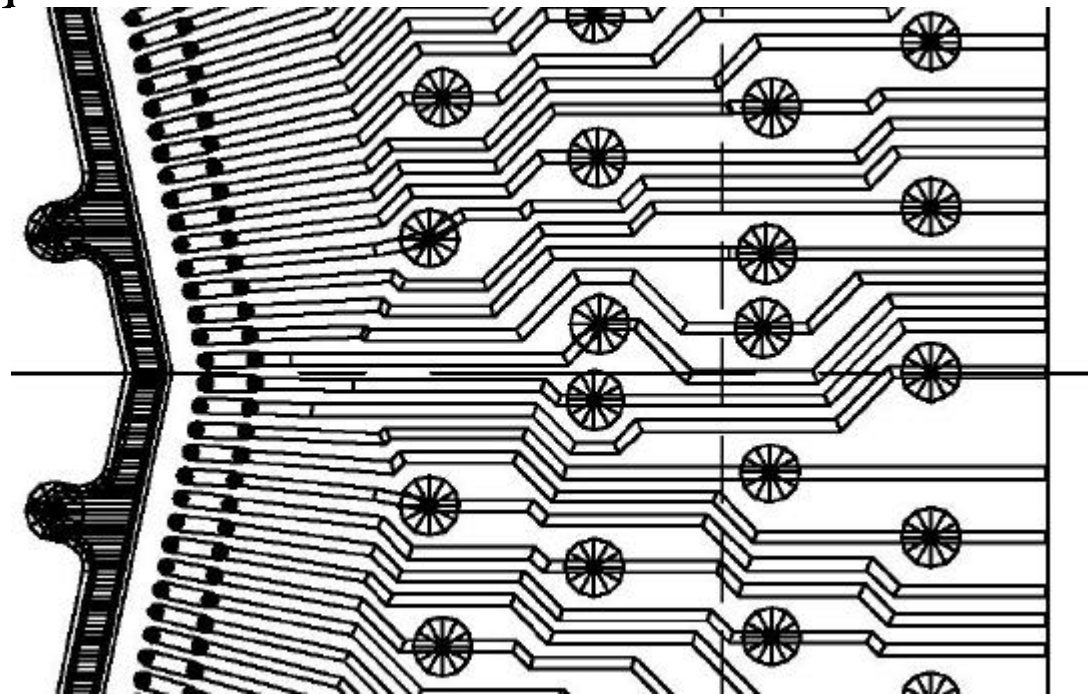


X-talk zoom



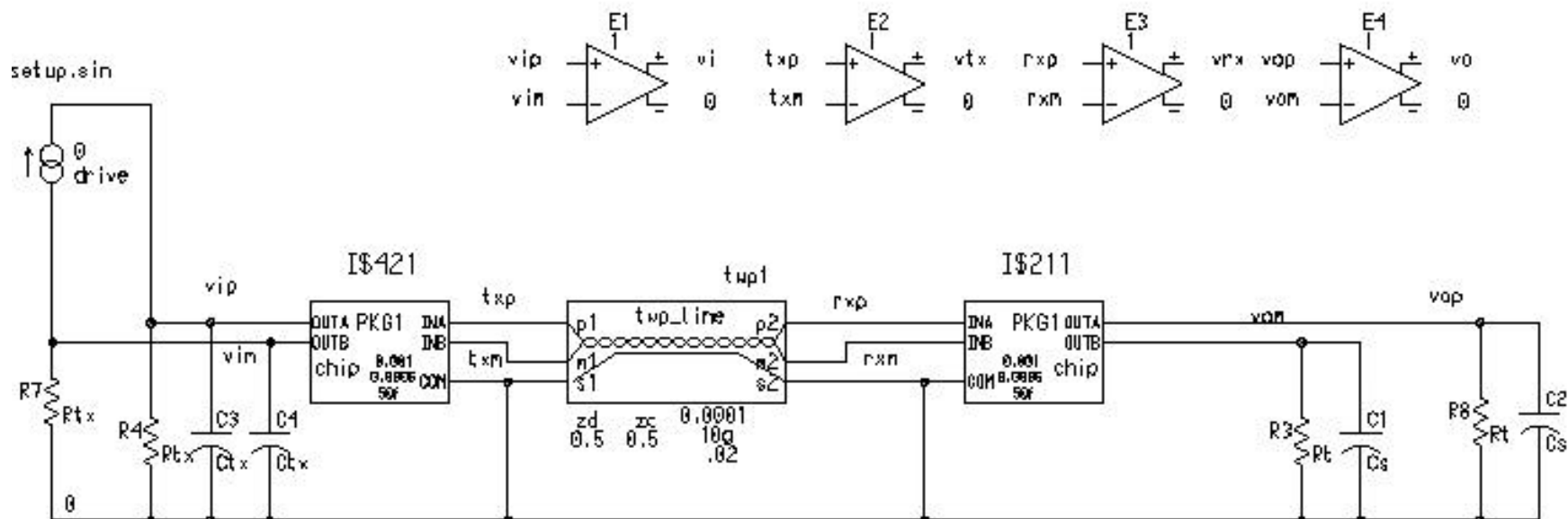
Plating stubs

- EPBGA Package Shown
- Bond-site is to the left, Package connection is the dot and the “back-stub” extends to the right
- The long ones are about 3-4 mm long
- Back-stubs required in manufacture of PBGA and EPBGA packages

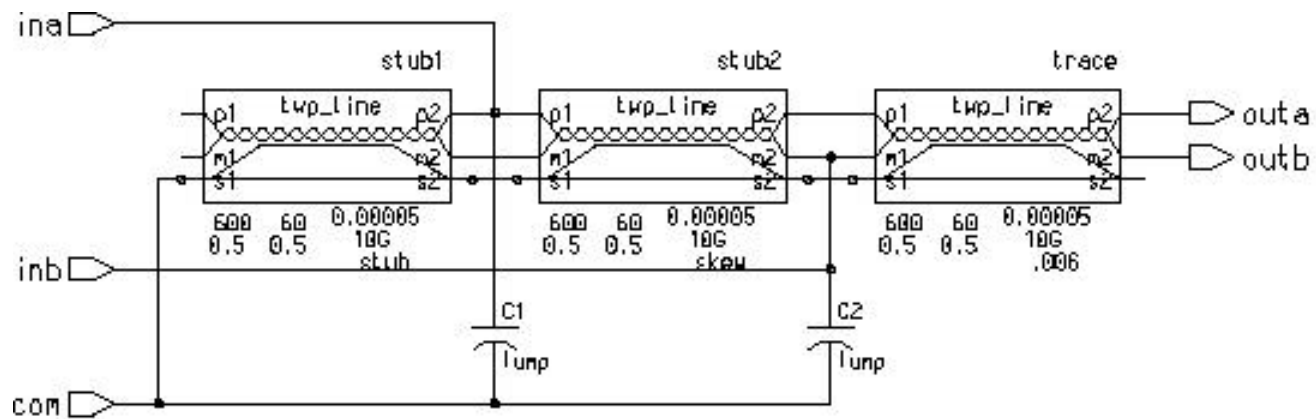


Plating stub models

Top level test bench

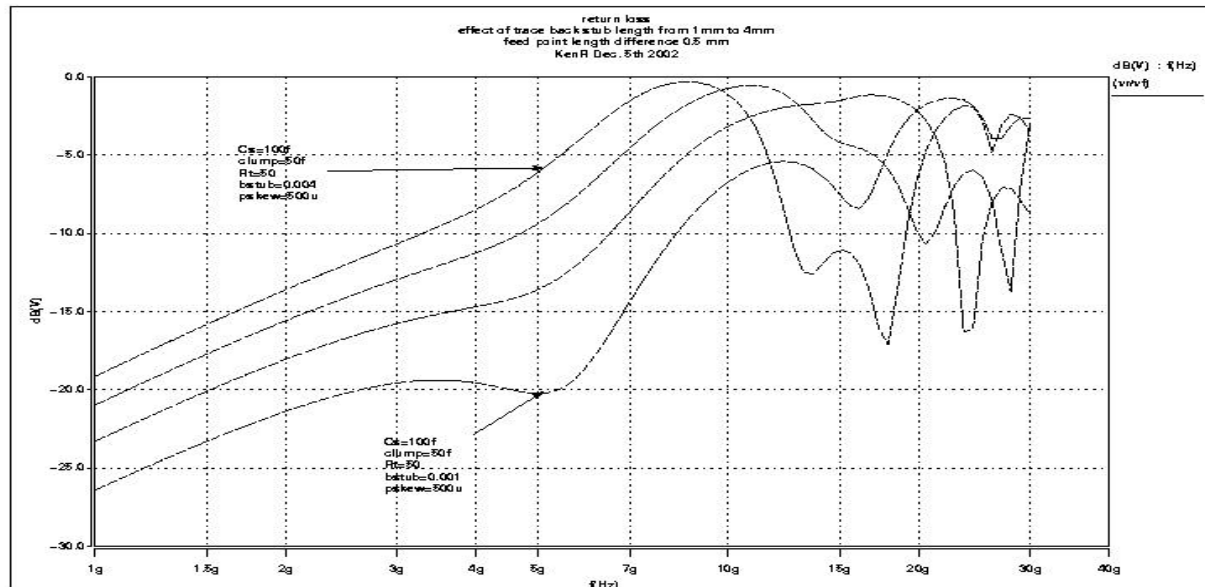


Plating stub models



Plating stubs

- At 5GHz >1mm stubs can cause signal integrity problems
- Only trace that meets the XFI Return Loss spec. is the lowest one



Comments

- RLGc models o.k. for narrow BW
- Better models are needed for $> 1:5$ frequency range typical of serial PHYs
- The Hspice W element is very complete and will work with multi-octave bandwidths
- Simpler models are also useful

Where to start?

- Estimate physical parameters from geometry, easier than L,C directly
- Set impedances to match TDR/network analyser data
- Try $\text{SQRT}(L/C)$ from lumped after correcting for K factor
- Use a good EM solver

Parting shots...

If you see a system signal specification that is not measured at the termination point of a transmission line into a matched load you should:

- A. Run
- B. Tell them “We’ll get back to you on that.”
- C. Offer to sell the authors the Brooklyn Bridge
- D. All of the above